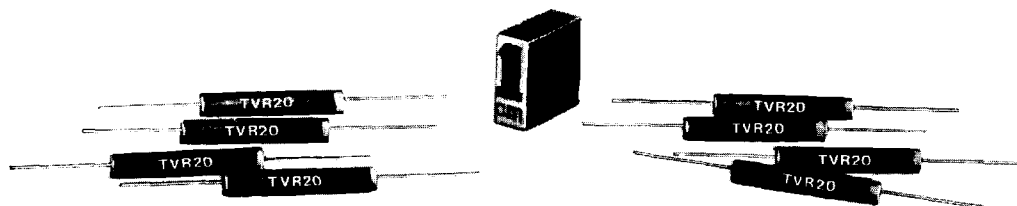


HIGH VOLTAGE FAST RECOVERY SILICON DIODE FOR CRT APPLICATIONS TYPE—TVR 20



This high voltage fast recovery diode was developed for assembly or encapsulation and is intended primarily for use as a building block in the assembly of high voltage circuits for black / white TV and similar service.

ABSOLUTE MAXIMUM RATINGS

Peak Reverse Voltage—Repetitive	V_{RWM} max.	20,000 Volts
* Average Forward Current	I_F (AV) max.	1.0 mA
* Peak Forward Current—Repetitive	I_{FRM} max.	200 mA
** Operating Temperature	T_A	+ 100°C
Storage Temperature Range	T_{stg}	-55°C to + 150°C

* Pulse rectifier service—TV deflection system, duty cycle approximately 15% of one horizontal cycle
Approximately 10 usec at a repetition rate of 15,750 Hz.

** See Figure 2 (over)

ELECTRICAL CHARACTERISTICS @ $T_A = 25^\circ\text{C}$, unless otherwise indicated.

Forward Voltage V_F @ $I_F = 5\text{mA}$	30V max.
* Reverse Current I_R @ $V_R = 20\text{KV}$	1 μA max.
* Reverse Current @ $T_A = 100^\circ\text{C}$, I_R @ $V_R = 20\text{KV}$	10 μA max.
Reverse Recovery (Fig. 3) t_{rr}	100 nanosec max.

* Tested in suitable dielectric medium

EDI reserves the right to change these specifications at any time without notice.



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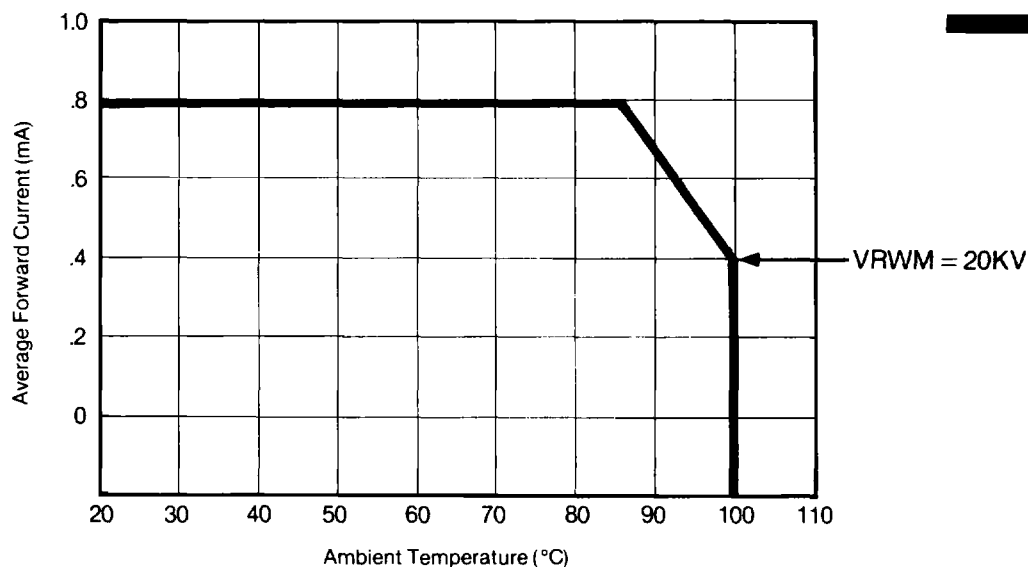


FIG. 1 Maximum Average Forward Current vs. Ambient Temperature (°C)

FIG. 2 TYPICAL APPLIED VOLTAGE

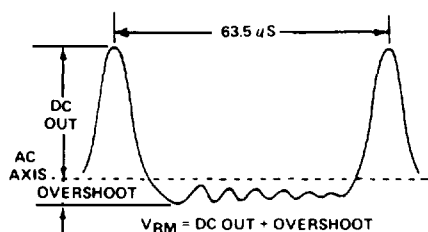


FIG. 3 TYPICAL OPERATING CIRCUIT

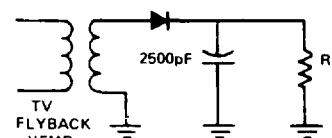


FIG. 4 REVERSE RECOVERY TEST METHOD

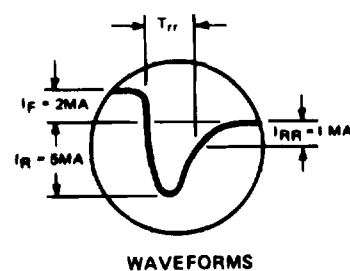
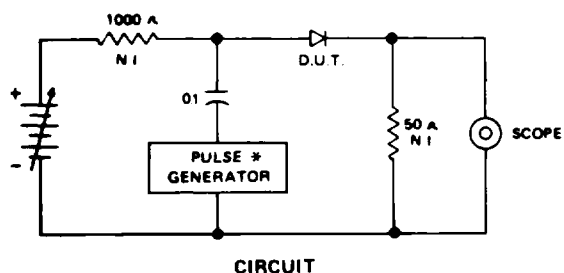
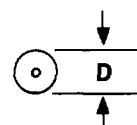
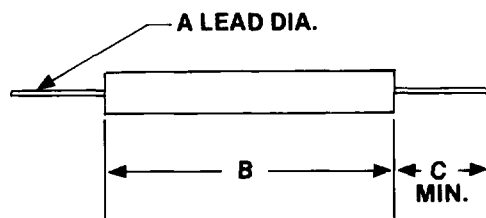


FIG. 5 MECHANICAL OUTLINE

*PULSE GENERATOR
HP 214 A OR EQUIV.
PULSE WIDTH 1 μS
REP. RATE 10 HKZ



	INCHES	MM
A	.020	0.51
B	1.5	38.1
C	0.5	12.7
D	.235	5.97

Notes:

1. molding material rated UL94V - 0
2. max. lead temperature for soldering, $1/8$ " from body, 10 seconds @ 260° C.